


<b>Search Notes</b>  	<b>Application/Control No.</b>  10549630	<b>Applicant(s)/Patent Under Reexamination</b>  ITOH ET AL.
	<b>Examiner</b>  JENNIFER Y CHO	<b>Art Unit</b>  1621

SEARCHED			
Class	Subclass	Date	Examiner
558	174	2/26/08	JC

SEARCH NOTES		
Search Notes	Date	Examiner
Updated East Search and Inventor Search	2/26/08	JC
STIC search	2/5/08	STIC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
558	174	2/26/08	JC